

600 nA, Rail-to-Rail Input/Output Op Amps

Features

- Low Quiescent Current: 600 nA/Amplifier (typ)
- Rail-to-Rail Input: -0.3V to V_{DD}+0.3V
- Rail-to-Rail Output: V_{SS}+0.1V to V_{DD}-0.1V
- · Gain Bandwidth Product: 14 kHz (typ)
- Wide Supply Voltage Range: 1.4V to 5.5V
- · Unity Gain Stable
- · Available in Single, Dual, and Quad
- Chip Select (CS) with MCP6043

Applications

- · Toll Both Tags
- · Wearable Products
- · Temperature Measurement
- · Battery Powered

Available Tools

- · Spice macro models (at www.microchip.com)
- FilterLab™ Software (at www.microchip.com)

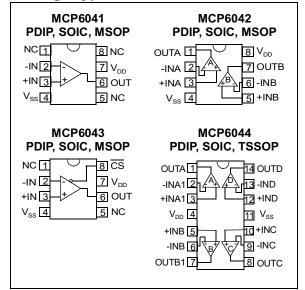
Description

The MCP6041/2/3/4 family of operational amplifiers from Microchip Technology, Inc. operate with a single supply voltage as low as 1.4V, while drawing less than 1 μ A of quiescent current per amplifier. These devices are also designed to support rail-to-rail input and output operation. This combination of features supports battery-powered and portable applications.

The MCP6041/2/3/4 amplifiers have a typical gain bandwidth product of 14 kHz and are unity gain stable. These specs make these operational amplifiers appropriate for low frequency applications, such as battery current monitoring and sensor conditioning.

The MCP6041/2/3/4 family operational amplifiers are offered in single (MCP6041), single with a Chip Select (CS) feature (MCP6043), dual (MCP6042) and quad (MCP6044) configurations.

Package Types



1.0 ELECTRICAL CHARACTERISTICS

1.1 <u>Maximum Ratings*</u>

V _{DD}	7.0V
All inputs and outputs w.r.t	V_{SS} –0.3V to V_{DD} +0.3V
Difference Input voltage	V _{DD} - V _{ss}
Output Short Circuit Current	continuous
Current at Input Pin	±2 mA
Current at Output and Supply Pins	±30 mA
Storage temperature	65°C to +150°C
Ambient temp. with power applied	55°C to +125°C
ESD protection on all pins (HBM)	≥4 kV

*Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

PIN FUNCTION TABLE

NAME	FUNCTION
+IN/+INA/+INB/+INC/+IND	Non-inverting Input Ter- minals
-IN/-INA/-INB/-INC/-IND	Inverting Input Terminals
V_{DD}	Positive Power Supply
V _{SS}	Negative Power Supply
OUT/OUTA/OUTB/OUTC/OUTD	Output Terminals
CS	Chip Select
NC	No internal connection to IC

DC CHARACTERISTICS

Unless otherwise indicated, all limits are spec R _L = 1 M Ω to V _{DD} /2, and V _{OUT} ~ V _{DD} /2	iffed for V _{DD} =	+1.4V to +	o.ov, v _{ss}	= GND, 1 _A =	= 25 °C, V _C	$_{M} = V_{DD}/Z,$
PARAMETERS	SYMBOL	MIN	TYP	MAX	UNITS	CONDITIONS
Input Offset						
Input Offset Voltage	Vos	-3	_	+3	mV	
Drift with Temperature,	dV _{os} /dT	_	±1.5	_	μV/°C	$T_A = -40$ °C to+85°C
Power Supply Rejection	PSRR	70	85		dB	
Input Bias Current and Impedance						
Input Bias Current	I _B	_	1	_	pА	
Input Bias Current Over Temperature	I _B	_	_	100	pА	$T_A = -40^{\circ}\text{C to} + 85^{\circ}$
Input Offset Current	I _{os}	_	1	_	pА	
Common Mode Input Impedance	Z _{CM}	_	10 ¹³ 6	_	ΩpF	
Differential Input Impedance	Z_{DIFF}		10 ¹³ 6	-	Ω pF	
Common Mode						
Common-Mode Input Range	VCMR	V _{SS} -0.3	_	V _{DD} +0.3	V	
Common-Mode Rejection Ratio	CMRR	62	80	_	dB	$V_{DD} = 5V, V_{CM} = -0.3 \text{ to}$ 5.3V
		60	75	_	dB	$V_{DD} = 5V, V_{CM} = 2.5V \text{ to}$ 5.3V
		60	80	_	dB	$V_{DD} = 5V, V_{CM} = -0.3 \text{ to}$ 2.5V
Open Loop Gain						
DC Open Loop Gain	A _{OL}	95	115	_	dB	$\label{eq:RL} \begin{split} R_{L} &= 50 \text{ k}\Omega \text{ to V}_{DD}/2, \\ 100 \text{ mV} &< V_{OUT} < (V_{DD} - \\ 100 \text{ mV}) \end{split}$
Output						
Maximum Output Voltage Swing	V_{OL}, V_{OH}	V _{SS} + 10	_	$V_{DD} - 10$	mV	$R_L = 50 \text{ k}\Omega \text{ to } V_{DD}/2$
Linear Region Output Voltage Swing	VOVR	V _{SS} + 100	_	$V_{DD} - 100$	mV	R_L = 50 k Ω to $V_{DD}/2$, $A_{OL} \ge 95$ dB
Output Short Circuit Current	Io	_	21	_	mA	$V_{OUT} = 2.5V, V_{DD} = 5V$
Power Supply						
Supply Voltage	V_{DD}	1.4	_	5.5	V	
Quiescent Current per amplifier	ΙQ	0.3	0.6	1.0	μΑ	I ₀ = 0

AC CHARACTERISTICS

Unless otherwise indicated, all limits are specified for V_{DD} = +5V, V_{SS} = GND, T_A = 25 °C, V_{CM} = $V_{DD}/2$, R_L = 1 M Ω to $V_{DD}/2$, C_L = 60 pF, and $V_{OUT} \sim V_{DD}/2$

-E F 7 001 BB									
PARAMETERS	SYMBOL	MIN	TYP	MAX	UNITS	CONDITIONS			
Gain Bandwidth Product	GBWP	_	14	_	kHz				
Slew Rate	SR	_	3.0	_	V/ms				
Phase Margin	PM	_	65	_	۰	G = +1			
Input Voltage Noise	En	_	5.0	_	µVр-р	f = 0.1 Hz to 10 Hz			
Input Voltage Noise Density	e _n	_	170	_	nV/√Hz	f = 1 kHz			
Input Current Noise Density	i _n	_	0.6	_	fA/√Hz	f = 1 kHz			

SPECIFICATIONS FOR MCP6043 CHIP SELECT FEATURE

Unless otherwise indicated, all limits are specified for V_{DD} = +1.4V to +5.5V, V_{SS} = GND, T_A = 25 °C, V_{CM} = $V_{DD}/2$, R_i = 1 M Ω to $V_{DD}/2$, C_i = 60 pF, and $V_{OUT} \sim V_{DD}/2$

$R_L = 1 \text{ M}\Omega$ to $V_{DD}/2$, $C_L = 60 \text{ pF}$, and $V_{OUT} \sim V_{DD}/2$									
PARAMETERS	SYMBOL	MIN	TYP	MAX	UNITS	CONDITIONS			
CS Low Specifications									
CS Logic Threshold, Low	V_{IL}	V _{ss}	_	V _{SS} + 0.3	V	For entire V _{DD} range			
CS Input Current, Low	I _{CSL}	_	5	_	pА	CS = V _{SS}			
CS High Specifications									
CS Logic Threshold, High	V_{IH}	V _{DD} - 0.3	_	V_{DD}	V	For entire V _{DD} range			
CS Input Current, High	I _{CSH}	_	5	_	pA	CS = V _{DD}			
CS Input High, GND Current	Ι _Q	_	20	_	pА	CS = V _{DD}			
Amplifier Output Leakage, CS High		_	20	_	pА	$\overline{\text{CS}} = \text{V}_{\text{DD}}$			
Dynamic Specifications									
CS Low to Amplifier Output High Turn-on Time	t _{on}	_	2	50	ms	$\overline{\text{CS}}$ low = V _{SS} + 0.3V, G = +1V/V, V _{OUT} = 0.9V _{DD} /2			
CS High to Amplifier Output High Z	t _{OFF}	_	10	_	μs	$\overline{\text{CS}}$ high = V _{DD} - 0.3V, G = +1V/V V _{OUT} = 0.1V _{DD} /2			
Hysteresis	V_{HYST}	_	0.6	_	V	V _{DD} = 5V			

TEMPERATURE SPECIFICATIONS

Unless otherwise indicated, all limits are specified for V_{DD} = +1.4V to +5.5V, V_{SS} = GND								
PARAMETERS	SYMBOL	MIN	TYP	MAX	UNITS	CONDITIONS		
Temperature Ranges								
Specified Temperature Range	T _A	-40		+85	°C			
Operating Temperature Range	T _A	-40		+85	°C			
Storage Temperature Range	T _A	-65		+150	°C			
Thermal Package Resistances								
Thermal Resistance, 8L-PDIP	θ_{JA}	_	85	_	°C/W			
Thermal Resistance, 8L-SOIC	θ_{JA}	_	163	_	°C/W			
Thermal Resistance, 8L-MSOP	θ_{JA}	_	206	_	°C/W			
Thermal Resistance, 14L-PDIP	θ_{JA}	_	70	_	°C/W			
Thermal Resistance, 14L-SOIC	θ_{JA}	_	120	_	°C/W			
Thermal Resistance, 14L-TSSOP	θ_{JA}	_	100	_	°C/W			

2.0 TYPICAL PERFORMANCE CURVES

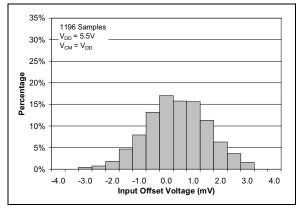


FIGURE 2-1: Histogram of Input Offset Voltage with $V_{DD} = 5.5V$, $V_{CM} = V_{DD}$

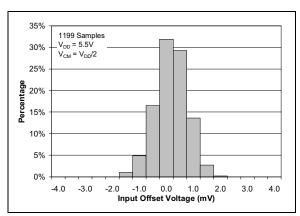


FIGURE 2-2: Histogram of Input Offset Voltage with $V_{DD} = 5.5V$, $V_{CM} = V_{DD}/2$

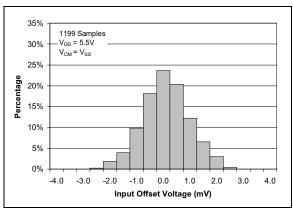


FIGURE 2-3: Histogram of Input Offset Voltage with $V_{DD} = 5.5 V$, $V_{CM} = V_{SS}$

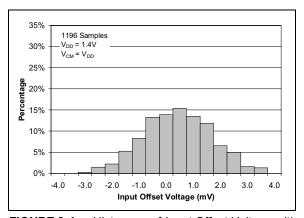


FIGURE 2-4: Histogram of Input Offset Voltage with $V_{DD} = 1.4V$, $V_{CM} = V_{DD}$

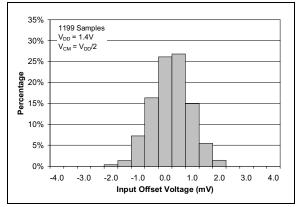


FIGURE 2-5: Histogram of Input Offset Voltage with $V_{DD} = 1.4V$, $V_{CM} = V_{DD}/2$

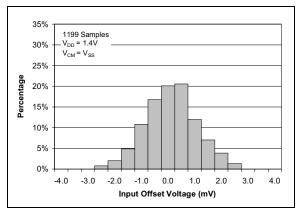


FIGURE 2-6: Histogram of Input Offset Voltage with $V_{DD} = 1.4V$, $V_{CM} = V_{SS}$

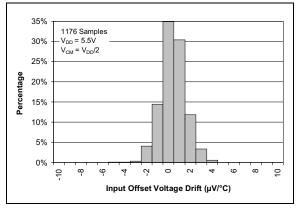


FIGURE 2-7: Histogram of Input Offset Voltage Drift with $V_{DD} = 5.5V$, $V_{CM} = V_{DD}/2$

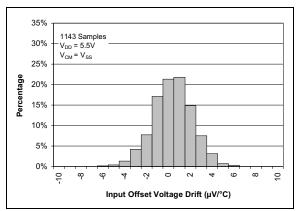


FIGURE 2-8: Histogram of Input Offset Voltage Drift with $V_{DD} = 5.5V$, $V_{CM} = V_{SS}$

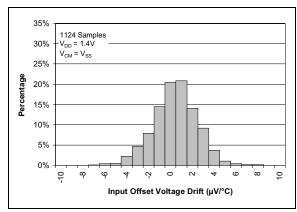


FIGURE 2-9: Histogram of Input Offset Voltage Drift with V_{DD} = 1.4V, V_{CM} = V_{SS}

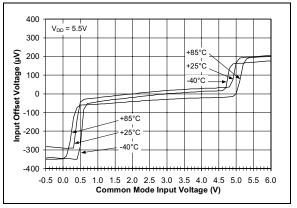


FIGURE 2-10: Input Offset Voltage vs. Common Mode Input Voltage vs. Temperature with $V_{DD} = 5.5V$

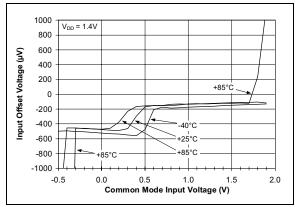


FIGURE 2-11: Input Offset Voltage vs. Common Mode Input Voltage vs. Temperature with $V_{DD} = 1.4V$

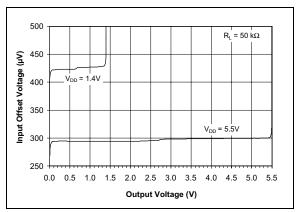


FIGURE 2-12: Input Offset Voltage vs. Output Voltage vs. Power Supply Voltage

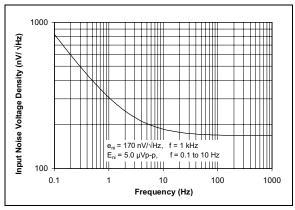


FIGURE 2-13: Input Noise Voltage Density vs. Frequency

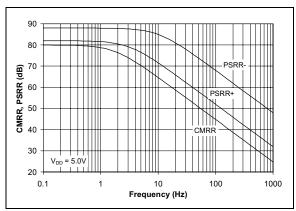


FIGURE 2-14: Common Mode Rejection Ratio, Power Supply Rejection Ratio vs. Frequency

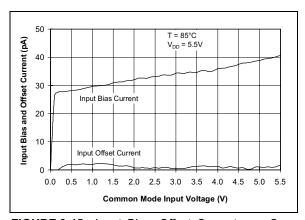


FIGURE 2-15: Input Bias, Offset Currents vs. Common Mode Input Voltage with Temperature = 85°C

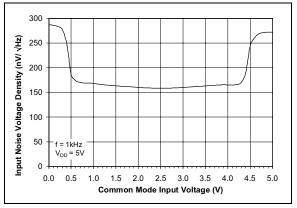


FIGURE 2-16: Input Noise Voltage Density vs. Common Mode Input Voltage

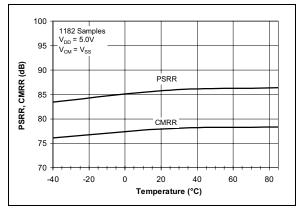


FIGURE 2-17: Common Mode Rejection Ratio, Power Supply Rejection Ratio vs. Temperature

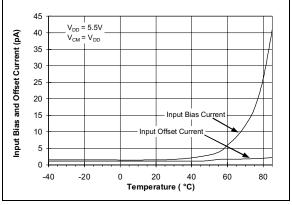


FIGURE 2-18: Input Bias, Offset Currents vs Temperature

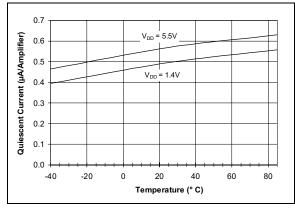


FIGURE 2-19: Quiescent Current vs. Temperature vs. Power Supply Voltage

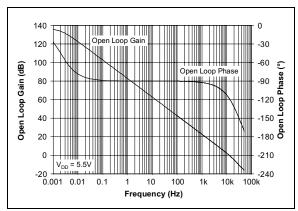


FIGURE 2-20: Open Loop Gain, Phase vs. Frequency with $V_{DD} = 5.5V$

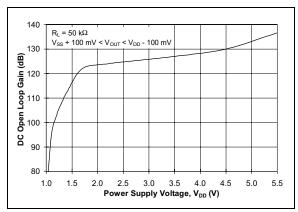


FIGURE 2-21: Open Loop Gain vs. Power Supply Voltage

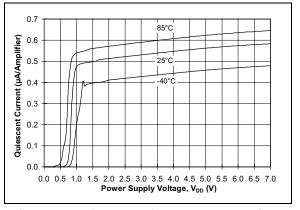


FIGURE 2-22: Quiescent Current Vs. Power Supply Voltage vs. Temperature

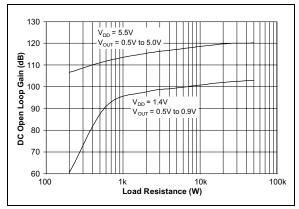


FIGURE 2-23: Open Loop Gain vs. Load Resistance vs. Power Supply Voltage

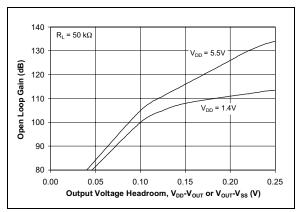


FIGURE 2-24: Open Loop Gain vs. Output Voltage Headroom vs. Power Supply Voltage

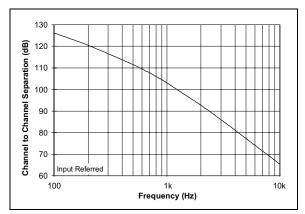


FIGURE 2-25: Channel to Channel Separation vs. Frequency (MCP6042 and MCP6044 only)

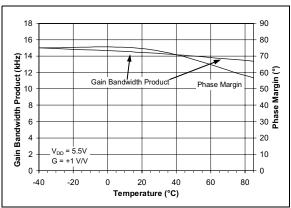


FIGURE 2-26: Gain Bandwidth Product, Phase Margin vs. Temperature with $V_{DD} = 5.5V$, Unity Gain

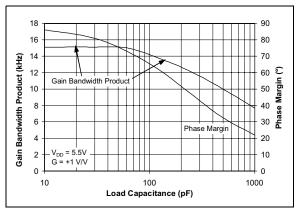


FIGURE 2-27: Gain Bandwidth Product, Phase Margin vs. Load Capacitance with Unity Gain

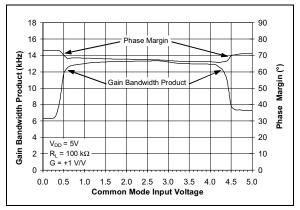


FIGURE 2-28: Gain Bandwidth Product, Phase Margin vs. Common Mode Input Voltage with Unity Gain

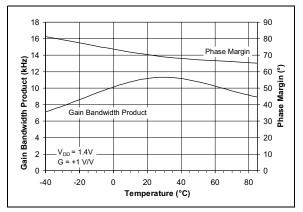


FIGURE 2-29: Gain Bandwidth Product, Phase Margin vs. Temperature with $V_{DD} = 1.4V$, Unity Gain

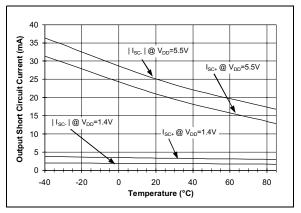


FIGURE 2-30: Output Short Circuit Current vs. Temperature vs. Power Supply Voltage

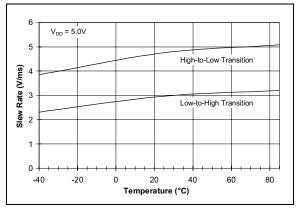


FIGURE 2-31: Slew Rate vs. Temperature

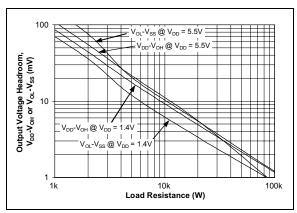


FIGURE 2-32: Output Voltage Headroom vs. Load Resistance vs. Power Supply Voltage

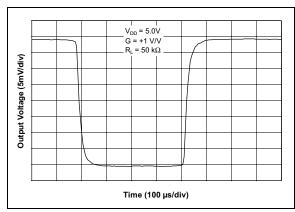


FIGURE 2-33: Small Signal Non-Inverting Pulse Response

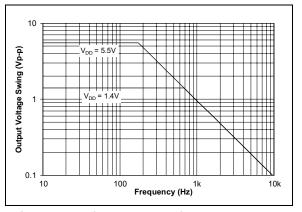


FIGURE 2-34: Output Voltage Swing vs. Frequency vs. Power Supply Voltage

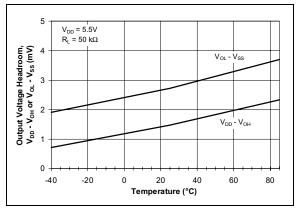


FIGURE 2-35: Output Voltage Headroom vs. Temperature

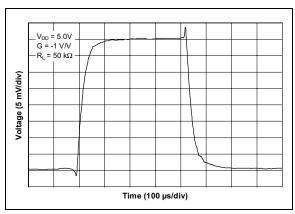


FIGURE 2-36: Small Signal Inverting Pulse Response

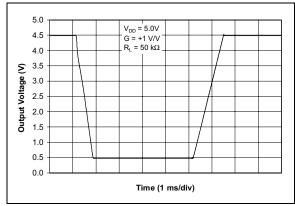


FIGURE 2-37: Large Signal Non-Inverting Pulse Response

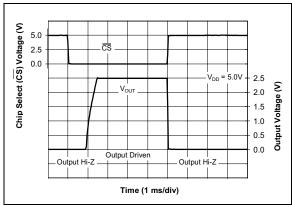


FIGURE 2-38: Chip Select ($\overline{\text{CS}}$) to Amplifier Output Response Time (MCP6043 only)

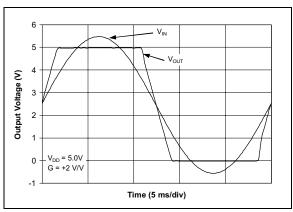


FIGURE 2-39: The MCP6041/2/3/4 family shows no phase reversal (for information only—the Maximum Absolute Input Voltage is still $V_{\rm SS}$ -0.3V and $V_{\rm DD}$ +0.3V)

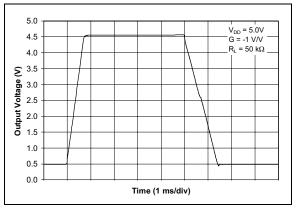


FIGURE 2-40: Large Signal Inverting Pulse Response

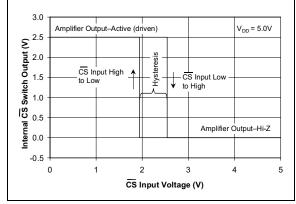


FIGURE 2-41: Chip Select (CS) Hysteresis (MCP6043 only)

3.0 APPLICATIONS INFORMATION

The MCP6041/2/3/4 family of operational amplifiers are fabricated on Microchip's state-of-the-art CMOS process. They are unity gain stable and suitable for a wide range of applications requiring very low power consumption. With these op amps, the power supply pin needs to be by-passed with a 0.1 μ F capacitor.

3.1 Rail to Rail Input

The input stage of the family of devices uses two differential input stages in parallel; one operates at low V_{CM} (common mode input voltage) and the other at high V_{CM} . With this topology, the MCP6041/2/3/4 family operates with V_{CM} up to 300 mV past either supply rail. The Input Offset Voltage is measured at both $V_{\text{CM}} = V_{\text{SS}} - 0.3 \text{V}$ and V_{DD} + 0.3V to ensure proper operation.

3.2 Output Loads and Battery Life

The MCP6041/2/3/4 op amp family has outstanding quiescent current, which supports battery-powered applications. There is minimal quiescent current glitching when chip select (\overline{CS}) is raised or lowered. This prevents excessive current draw, and reduced battery life, when the part is turned off or on.

Heavy resistive loads at the output can cause excessive battery drain. Driving a DC voltage of 2.5V across a 100 k Ω load resistor will cause the supply current to increase by 25 $\mu A,$ depleting the battery 43 times as fast as $I_{\rm Q}$ (0.6 $\mu A)$ alone.

High frequency signals (fast edge rate) across capacitive loads will also significantly increase supply current. For instance, a 0.1 μF capacitor at the output presents an AC impedance of 15.9 k Ω (1/2 πfC) to a 100 Hz sinewave. It can be shown that the average power drawn from the battery by a 5.0Vp-p sinewave (1.77Vrms), under these conditions, is:

$$\begin{split} P_{SUPPLY} &= (V_{DD} - V_{SS})(I_Q + V_{L(p-p)}fC_L) \\ &= (5V)(0.6\mu A + 5.0V_{p-p} \bullet 100Hz \bullet 0.1\mu F) \\ &= 3.0\mu W + 50\mu W \end{split}$$

This will drain the battery 18 times as fast as I_Q alone.

3.3 Rail to Rail Output

The output voltage range of the MCP6041/2/3/4 family is specified two ways. The first specification, Maximum Output Voltage Swing, defines the maximum swing possible under a particular output load. According to the spec table, the output can reach ≤ 10 mV of either supply rail when $R_L = 50~k\Omega.$ See Figure 2-32 for information on Maximum Output Voltage Swing vs. load resistance.

The second specification, Linear Region Output Voltage Swing, details the output voltage range that supports the specified Open Loop Gain (A $_{OL} \ge 95$ dB with R $_{I} = 50$ k Ω).

3.4 <u>Input Voltage and Phase Reversal</u>

The MCP6041/2/3/4 op amp family uses CMOS transistors at the input. It is designed to not exhibit phase inversion when the input pins exceed the supply voltages. Figure 2-39 shows an input voltage exceeding both supplies with no resulting phase inversion.

The maximum operating V_{CM} (common mode input voltage) that can be applied to the inputs is V_{SS} -0.3V and V_{DD} +0.3V. Voltage on the input that exceed this absolute maximum rating can cause excessive current to flow in or out of the input pins. Current beyond ±2 mA can cause possible reliability problems. Applications that exceed this rating must be externally limited with an input resistor as shown in Figure 3-1.

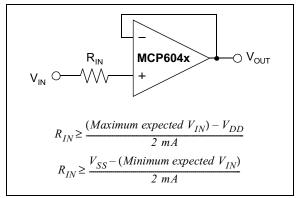


FIGURE 3-1: An input resistor, R_{IN} , should be used to limit excessive input current if the inputs exceed the Absolute Maximum specification

3.5 Capacitive Load and Stability

Driving capacitive loads can cause stability problems with voltage feedback op amps. A buffer configuration (G = +1) is the most sensitive to capacitive loads. Figure 2-27 shows how increasing the load capacitance will decrease the phase margin. A phase margin above 60° is best, but 45° is still usable. As can be seen, up to C_L = $150 \, \text{pF}$ can be placed on the MCP6041/2/3/4 op amp outputs without any problems, while $250 \, \text{pF}$ is useable with 45° phase margin.

When the op amp is required to drive large capacitive loads (C_L >150 pF), then a small series resistor ($R_{\rm ISO}$ in Figure 3-2) at the output of the amplifier improves the phase margin. This resistor makes the output load resistive at higher frequencies, which improves the phase margin. The bandwidth reduction caused by the capacitive load, however, is not changed. To select $R_{\rm ISO}$, start with 1 k Ω , then use the MCP6041 SPICE macro model and bench testing to adjust $R_{\rm ISO}$ until the frequency response peaking is reasonable. Use the smallest reasonable value.

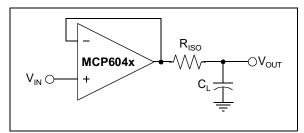


FIGURE 3-2: Amplifier circuit for heavy capacitive loads

3.6 The MCP6043 Chip Select (CS) Option

The MCP6043 is a single amplifier with a chip select (\overline{CS}) option. When \overline{CS} is pulled high the supply current drops to 20 pA (typ), and goes through the \overline{CS} pin to V_{SS} . When this happens, the amplifier is put into a high impedance state. By pulling \overline{CS} low, the amplifier is enabled. If the \overline{CS} pin is left floating, the amplifier will not operate properly. Figure 3-3 shows the output voltage and supply current response to a \overline{CS} pulse.

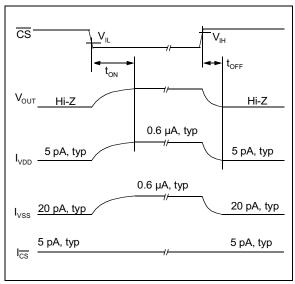


FIGURE 3-3: Timing Diagram for the $\overline{\text{CS}}$ function on the MCP6043 op amp

3.7 <u>Layout Considerations</u>

Good PC board layout techniques will help you achieve the performance shown in the specs and Typical Performance Curves. It will also help you minimize EMC (Electro-Magnetic Compatibility) issues.

3.7.1 SURFACE LEAKAGE

In applications where low input bias current is critical, PC board surface leakage effects and signal coupling from trace to trace need to be considered.

Surface leakage is caused by a difference in voltage between traces, combined with high humidity, dust or other contamination on the board. Under low humidity conditions, a typical resistance between nearby traces is $10^{12}\Omega$. A 5V difference would cause 5 pA of current to flow; this is greater than the input current of the MCP6041/2/3/4 family at 25°C (1 pA, typ).

The simplest technique to reduce surface leakage is using a guard ring around sensitive pins (or traces). The guard ring is biased at the same voltage as the sensitive pin or trace; Figure 3-4 shows an example of a typical layout.

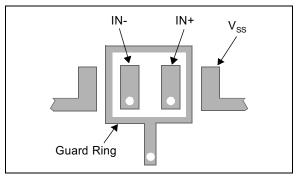


FIGURE 3-4: Example of Guard Ring layout

Circuit schematics for different guard ring implementations are shown in Figure 3-5. Figure 3-5A biases the guard ring to the input common mode voltage, which is most effective for non-inverting gains, including unity gain. Figure 3-5B biases the guard ring to a reference voltage ($V_{\rm REF}$, which can be ground). This is useful for inverting gains and precision photo sensing circuits.

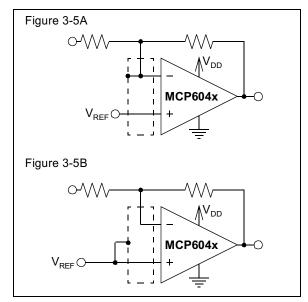


FIGURE 3-5: Two possible guard ring connection strategies to reduce surface leakage effects

3.7.2 COMPONENT PLACEMENT

Separate digital from analog, and low speed from high speed. This helps prevent crosstalk.

Keep sensitive traces short and straight. Separate them from interfering components and traces. This is especially important for high frequency (low rise time) signals.

Use a 0.1 μ F supply bypass capacitor within 0.1" (2.5 mm) of the V_{DD} pin. It must connect directly to the ground plane.

3.7.3 SIGNAL COUPLING

The input pins of the MCP6041/2/3/4 family of op amps are high impedance, which allows noise injection. This noise can be capacitively or magnetically coupled. In either case, using a ground plane helps reduce noise injection.

When noise is coupled capacitively, the ground plane provides shunt capacitance to ground for high frequency signals; Figure 3-6 shows the equivalent circuit. The coupled current, I_M , produces a lower voltage $(V_{TRACE\ 2})$ on the victim trace when the trace to ground plane capacitance (C_{SH2}) is large, and the terminating resistor (R_{T2}) is small. Increasing the distance between traces, and using wider traces, also helps.

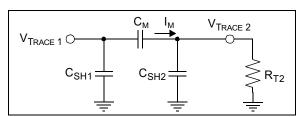


FIGURE 3-6: Equivalent circuit for capacitive coupling between traces on a PC board (with ground plane)

When noise is coupled magnetically, ground plane reduces the mutual inductance between traces. This occurs because the ground return current at high frequencies will follow a path directly beneath the signal trace. Increasing the separation between traces makes a significant difference. Changing the direction of one of the traces can also reduce magnetic coupling.

If these techniques are not enough, it may help to place guard traces next to the victim trace. They should be on both sides of the victim trace, and as close as possible. Connect the guard traces to ground plane at both ends, and in the middle for long traces.

3.8 <u>Typical Applications</u>

3.8.1 BATTERY CURRENT SENSING

The MCP6041/2/3/4 op amps' Common Mode Input Range, which goes 300 mV beyond both supply rails, supports their use in high side and low side battery current sensing applications. The very low quiescent current (0.6 µA, typ) help prolong battery life, and the rail-to-rail output allows you to detect low currents.

Figure 3-7 shows a high side battery current sensor circuit. The 10 Ω resistors are sized to minimize power losses. The battery current (I_{DD}) through the 10 Ω resistor causes its top terminal to be more negative than the bottom terminal. This keeps the common mode input voltage of the op amp \leq V_{DD}, which is within its allowed range. The output of the op amp can reach V_{DD} - 0.1mV (see Figure 2-32), which is a smaller error than the offset voltage.

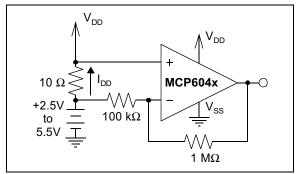


FIGURE 3-7: High Side Battery Current Sensor

3.8.2 INSTRUMENTATION AMPLIFIER

The MCP6041/2/3/4 op amp is well suited for conditioning sensor signals in battery-powered applications. Figure 3-8 shows a two op amp instrumentation amplifier, using the MCP6042, that works well for applications requiring rejection of common mode noise at higher gains. The reference voltage (V_{REF}) is supplied by a low impedance source. In single supply applications, V_{REF} is typically $V_{DD}/2$.

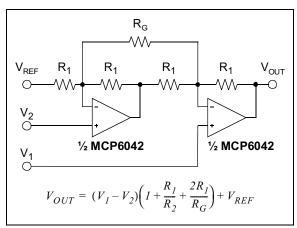


FIGURE 3-8: Two Op Amp Instrumentation Amplifier

4.0 SPICE MACRO MODEL

The Spice macro model for the MCP6041, MCP6042, MCP6043 and MCP6044 simulates the typical amplifier performance of: offset voltage, DC power supply rejection, input capacitance, DC common mode rejection, open loop gain over frequency, phase margin, output swing, DC power supply current, power supply current change with supply voltage, input common mode range, output voltage range vs. load, and input voltage noise.

The characteristics of the MCP6041, MCP6042, MCP6043, and MCP6044 amplifiers are similar in terms of performance and behavior. This single op amp macro model supports all four devices with the exception of the chip select function of the MCP6043, which is not modeled.

The listing for this macro model is shown on the next page. The most recent revision of the model can be downloaded from Microchip's web site at www.microchip.com.

Software License Agreement

The software supplied herewith by Microchip Technology Incorporated (the "Company") is intended and supplied to you, the Company's customer, for use solely and exclusively on Microchip products.

The software is owned by the Company and/or its supplier, and is protected under applicable copyright laws. All rights are reserved. Any use in violation of the foregoing restrictions may subject the user to criminal sanctions under applicable laws, as well as to civil liability for the breach of the terms and conditions of this license.

THIS SOFTWARE IS PROVIDED IN AN "AS IS" CONDITION. NO WARRANTIES, WHETHER EXPRESS, IMPLIED OR STATUTORY, INCLUDING, BUT NOT LIMITED TO, IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE APPLY TO THIS SOFTWARE. THE COMPANY SHALL NOT, IN ANY CIRCUMSTANCES, BE LIABLE FOR SPECIAL, INCIDENTAL OR CONSEQUENTIAL DAMAGES, FOR ANY REASON WHATSOEVER.

```
.SUBCKT MCP6041 1 2 3 4 5
                | | Output
                  | | Negative Supply
                 | Positive Supply
                | Inverting Input
               Non-inverting Input
* Macromodel for the MCP6041/2/3/4 op amp family:
   MCP6041 (single)
   MCP6042 (dual)
   MCP6043 (single w/ CS; chip select is not modeled)
   MCP6044 (quad)
* Revision History:
   REV A: 7-9-01 created KEB
* Recommendations:
   Use PSPICE (other simulators may require translation)
   For a quick, effective design, use a combination of: data sheet
     specs, bench testing, and simulations with this macromodel
   For high impedance circuits, set {\tt GMIN=100F} in the .OPTIONS
     statement
* Supported:
   Typical performance at room temperature (25 degrees C)
   DC, AC, Transient, and Noise analyses.
   Most specs, including: offsets, PSRR, CMRR, input impedance,
     open loop gain, voltage ranges, supply current, ..., etc.
* Not Supported:
   Chip Select (MCP6043)
   Variation in specs vs. Power Supply Voltage
    Distortion (detailed non-linear behavior)
   Temperature analysis
   Process variation
   Behavior outside normal operating region
* Input Stage
V10 3 10 -0.3
R10 10 11 78K
R11 10 12 78K
C11 11 12 4.9P
C12 1 0 6P
E12 1 14 POLY(4) 20 0 21 0 26 0 27 0 1M 1 1 1 1
G12 14 0 POLY(2) 22 0 23 0 1.5P 1U 1U
M12 11 14 15 15 NMI
C13 14 2 3P
M14 12 2 15 15 NMI
G14 2 0 POLY(2) 24 0 25 0 0.5P 1U 1U
C14 2 0 6P
```

```
I15 15 4 500N
V16 16 4 0.18
D16 16 15 DL
V13 3 13 0.00
D13 14 13 DL
* Noise Sources
I20 21 20 17.2N
D20 20 0 DN1
D21 0 21 DN1
I22 23 22 588U
D22 22 0 DN23
D23 0 23 DN23
I24 25 24 588U
D24 24 0 DN23
D25 0 25 DN23
* PSRR and CMRR
G26 0 26 POLY(1) 3 4 110U -20U
R26 26 0 1
G27 0 27 POLY(2) 1 3 2 4 -275U 50U 50U
R27 27 0 1
* Open Loop Gain, Slew Rate
G30 0 30 POLY(1) 12 11 0 1MEG
R30 30 0 1
C30 30 0 11.4
G31 0 31 POLY(1) 30 0 0 1
R31 31 0 1
C31 31 0 775N
* Output Stage
G40 0 40 POLY(1) 45 5 0 22.7M
D41 40 41 DL
R41 41 0 1K
D42 42 40 DL
R42 42 0 1K
G43 3 0 POLY(1) 41 0 100N 1M
G47 0 4 POLY(1) 42 0 100N -1M
E43 43 0 POLY(1) 3 0
E47 47 0 POLY(1) 4 0
V44 43 44 1M
D44 45 44 DLS
D46 46 45 DLS
V46 46 47 1M
G45 47 45 POLY(2) 31 0 3 4 0 8U 4U
R45 45 47 125K
R48 45 5 44
C48 5 0 2P
* Models
.MODEL NMI NMOS L=2 W=42
.MODEL DL D N=1 IS=1F
.MODEL DLS D N=1M IS=1F
.MODEL DN1 D IS=1F KF=1.13E-18 AF=1
.MODEL DN23 D IS=1F KF=3E-20
.ENDS MCP6041
```

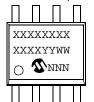
5.0 PACKAGING INFORMATION

5.1 Package Marking Information









8-Lead MSOP



Example:



Example:



Example:



Legend: XX...X Customer specific information*

YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

NNN Alphanumeric traceability code

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line thus limiting the number of available characters

for customer specific information.

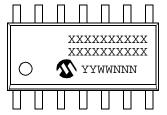
* Standard marking consists of Microchip part number, year code, week code, traceability code (facility code, mask rev#, and assembly code). For marking beyond this, certain price adders apply. Please check with your Microchip Sales Office.

Package Marking Information (Continued)

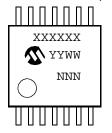




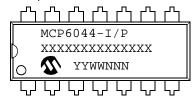




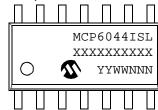
14-Lead TSSOP (MCP6044)



Example:



Example:



Example:



Legend: XX...X Customer specific information*

YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

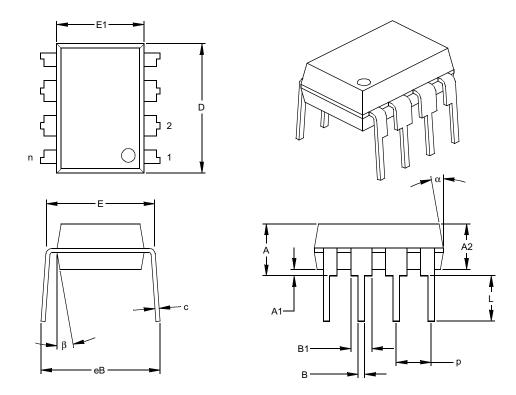
NNN Alphanumeric traceability code

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line thus limiting the number of available characters

for customer specific information.

* Standard marking consists of Microchip part number, year code, week code, traceability code (facility code, mask rev#, and assembly code). For marking beyond this, certain price adders apply. Please check with your Microchip Sales Office.

8-Lead Plastic Dual In-line (P) – 300 mil (PDIP)



	Units		INCHES*		N	IILLIMETERS	3
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.100			2.54	
Top to Seating Plane	Α	.140	.155	.170	3.56	3.94	4.32
Molded Package Thickness	A2	.115	.130	.145	2.92	3.30	3.68
Base to Seating Plane	A1	.015			0.38		
Shoulder to Shoulder Width	Е	.300	.313	.325	7.62	7.94	8.26
Molded Package Width	E1	.240	.250	.260	6.10	6.35	6.60
Overall Length	D	.360	.373	.385	9.14	9.46	9.78
Tip to Seating Plane	L	.125	.130	.135	3.18	3.30	3.43
Lead Thickness	С	.008	.012	.015	0.20	0.29	0.38
Upper Lead Width	B1	.045	.058	.070	1.14	1.46	1.78
Lower Lead Width	В	.014	.018	.022	0.36	0.46	0.56
Overall Row Spacing §	eВ	.310	.370	.430	7.87	9.40	10.92
Mold Draft Angle Top	α	5	10	15	5	10	15
Mold Draft Angle Bottom	β	5	10	15	5	10	15

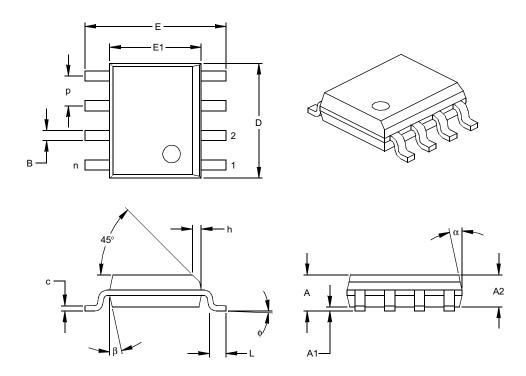
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC Equivalent: MS-001

Drawing No. C04-018

^{*} Controlling Parameter § Significant Characteristic

8-Lead Plastic Small Outline (SN) - Narrow, 150 mil (SOIC)



	Units		INCHES*		MILLIMETERS		
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.050			1.27	
Overall Height	Α	.053	.061	.069	1.35	1.55	1.75
Molded Package Thickness	A2	.052	.056	.061	1.32	1.42	1.55
Standoff §	A1	.004	.007	.010	0.10	0.18	0.25
Overall Width	Е	.228	.237	.244	5.79	6.02	6.20
Molded Package Width	E1	.146	.154	.157	3.71	3.91	3.99
Overall Length	D	.189	.193	.197	4.80	4.90	5.00
Chamfer Distance	h	.010	.015	.020	0.25	0.38	0.51
Foot Length	L	.019	.025	.030	0.48	0.62	0.76
Foot Angle	ф	0	4	8	0	4	8
Lead Thickness	С	.008	.009	.010	0.20	0.23	0.25
Lead Width	В	.013	.017	.020	0.33	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15

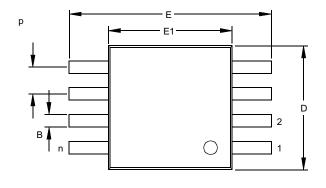
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

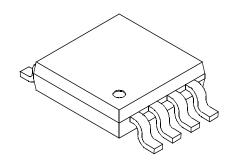
.010" (0.254mm) per side. JEDEC Equivalent: MS-012

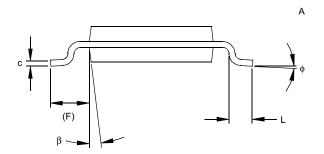
Drawing No. C04-057

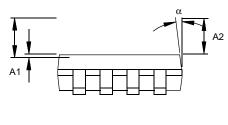
^{*} Controlling Parameter § Significant Characteristic

8-Lead Plastic Micro Small Outline Package (MS) (MSOP)









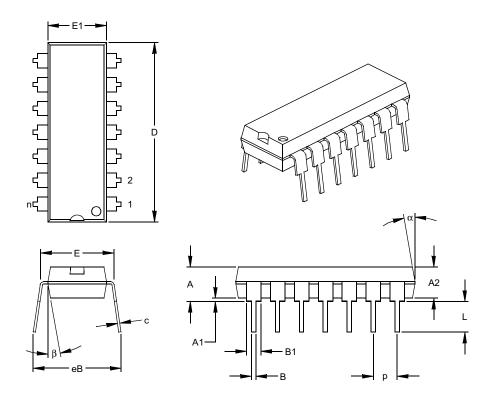
	Units		INCHES			ILLIMETERS*	
Dimen:	sion Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8				8
Pitch	р		.026			0.65	
Overall Height	Α			.044			1.18
Molded Package Thickness	A2	.030	.034	.038	0.76	0.86	0.97
Standoff §	A1	.002		.006	0.05		0.15
Overall Width	E	.184	.193	.200	4.67	4.90	.5.08
Molded Package Width	E1	.114	.118	.122	2.90	3.00	3.10
Overall Length	D	.114	.118	.122	2.90	3.00	3.10
Foot Length	L	.016	.022	.028	0.40	0.55	0.70
Footprint (Reference)	F	.035	.037	.039	0.90	0.95	1.00
Foot Angle	ф	0		6	0		6
Lead Thickness	С	.004	.006	.008	0.10	0.15	0.20
Lead Width	В	.010	.012	.016	0.25	0.30	0.40
Mold Draft Angle Top	α		7			7	
Mold Draft Angle Bottom	β		7			7	

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

Drawing No. C04-111

^{*}Controlling Parameter § Significant Characteristic

14-Lead Plastic Dual In-line (P) – 300 mil (PDIP)



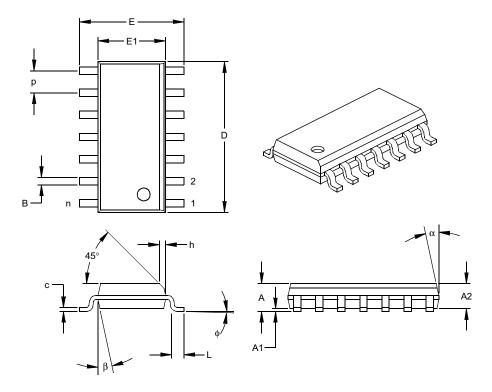
	Units		INCHES*		MILLIMETERS		
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		14			14	
Pitch	р		.100			2.54	
Top to Seating Plane	Α	.140	.155	.170	3.56	3.94	4.32
Molded Package Thickness	A2	.115	.130	.145	2.92	3.30	3.68
Base to Seating Plane	A1	.015			0.38		
Shoulder to Shoulder Width	Е	.300	.313	.325	7.62	7.94	8.26
Molded Package Width	E1	.240	.250	.260	6.10	6.35	6.60
Overall Length	D	.740	.750	.760	18.80	19.05	19.30
Tip to Seating Plane	L	.125	.130	.135	3.18	3.30	3.43
Lead Thickness	С	.008	.012	.015	0.20	0.29	0.38
Upper Lead Width	B1	.045	.058	.070	1.14	1.46	1.78
Lower Lead Width	В	.014	.018	.022	0.36	0.46	0.56
Overall Row Spacing §	eВ	.310	.370	.430	7.87	9.40	10.92
Mold Draft Angle Top	α	5	10	15	5	10	15
Mold Draft Angle Bottom	β	5	10	15	5	10	15

Notes:
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.010" (0.254mm) per side.
JEDEC Equivalent: MS-001
Drawing No. C04-005

^{*} Controlling Parameter § Significant Characteristic

14-Lead Plastic Small Outline (SL) - Narrow, 150 mil (SOIC)



	Units	INCHES*			MILLIMETERS		
Dimension	n Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		14			14	
Pitch	р		.050			1.27	
Overall Height	Α	.053	.061	.069	1.35	1.55	1.75
Molded Package Thickness	A2	.052	.056	.061	1.32	1.42	1.55
Standoff §	A1	.004	.007	.010	0.10	0.18	0.25
Overall Width	E	.228	.236	.244	5.79	5.99	6.20
Molded Package Width	E1	.150	.154	.157	3.81	3.90	3.99
Overall Length	D	.337	.342	.347	8.56	8.69	8.81
Chamfer Distance	h	.010	.015	.020	0.25	0.38	0.51
Foot Length	L	.016	.033	.050	0.41	0.84	1.27
Foot Angle	ф	0	4	8	0	4	8
Lead Thickness	С	.008	.009	.010	0.20	0.23	0.25
Lead Width	В	.014	.017	.020	0.36	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15

Notes:

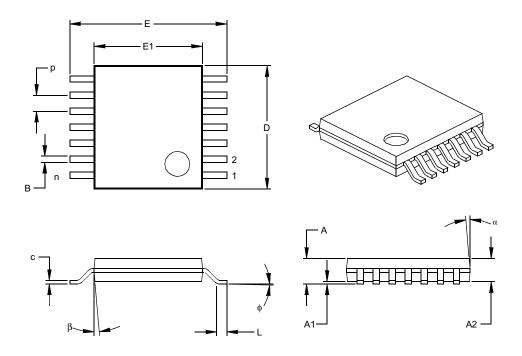
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC Equivalent: MS-012

Drawing No. C04-065

^{*} Controlling Parameter § Significant Characteristic

14-Lead Plastic Thin Shrink Small Outline (ST) – 4.4 mm (TSSOP)



	Units		INCHES		N	IILLIMETERS	S*
Dimension	Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		14			14	
Pitch	р		.026			0.65	
Overall Height	Α			.043			1.10
Molded Package Thickness	A2	.033	.035	.037	0.85	0.90	0.95
Standoff §	A1	.002	.004	.006	0.05	0.10	0.15
Overall Width	Е	.246	.251	.256	6.25	6.38	6.50
Molded Package Width	E1	.169	.173	.177	4.30	4.40	4.50
Molded Package Length	D	.193	.197	.201	4.90	5.00	5.10
Foot Length	L	.020	.024	.028	0.50	0.60	0.70
Foot Angle	ф	0	4	8	0	4	8
Lead Thickness	С	.004	.006	.008	0.09	0.15	0.20
Lead Width	B1	.007	.010	.012	0.19	0.25	0.30
Mold Draft Angle Top	α	0	5	10	0	5	10
Mold Draft Angle Bottom	β	0	5	10	0	5	10

Notes: Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed

.005" (0.127mm) per side. JEDEC Equivalent: MO-153 Drawing No. C04-087

^{*} Controlling Parameter § Significant Characteristic

ON-LINE SUPPORT

Microchip provides on-line support on the Microchip World Wide Web (WWW) site.

The web site is used by Microchip as a means to make files and information easily available to customers. To view the site, the user must have access to the Internet and a web browser, such as Netscape or Microsoft Explorer. Files are also available for FTP download from our FTP site.

Connecting to the Microchip Internet Web Site

The Microchip web site is available by using your favorite Internet browser to attach to:

www.microchip.com

The file transfer site is available by using an FTP service to connect to:

ftp://ftp.microchip.com

The web site and file transfer site provide a variety of services. Users may download files for the latest Development Tools, Data Sheets, Application Notes, User's Guides, Articles and Sample Programs. A variety of Microchip specific business information is also available, including listings of Microchip sales offices, distributors and factory representatives. Other data available for consideration is:

- · Latest Microchip Press Releases
- Technical Support Section with Frequently Asked Questions
- · Design Tips
- · Device Errata
- Job Postings
- · Microchip Consultant Program Member Listing
- Links to other useful web sites related to Microchip Products
- Conferences for products, Development Systems, technical information and more
- · Listing of seminars and events

Systems Information and Upgrade Hot Line

The Systems Information and Upgrade Line provides system users a listing of the latest versions of all of Microchip's development systems software products. Plus, this line provides information on how customers can receive any currently available upgrade kits. The Hot Line Numbers are:

1-800-755-2345 for U.S. and most of Canada, and 1-480-792-7302 for the rest of the world.

013001

READER RESPONSE

It is our intention to provide you with the best documentation possible to ensure successful use of your Microchip product. If you wish to provide your comments on organization, clarity, subject matter, and ways in which our documentation can better serve you, please FAX your comments to the Technical Publications Manager at (480) 792-4150.

Please list the following information, and use this outline to provide us with your comments about this Data Sheet.

RE:	Toominaari abilaatione Manager	Total Pages Sent					
Fro	Company	FAX: ()					
	pplication (optional):						
Wo	/ould you like a reply?YN						
	evice. WICF 004 1/2/3/4	nber: DS21669A					
Que	uestions:						
1.	. What are the best features of this document?						
2.	How does this document meet your hardware and software development needs?						
3.	. Do you find the organization of this data sheet easy to follow? If not, why?						
4.	What additions to the data sheet do you think w	ould enhance the structure and subject?					
		•					
_							
5.	. What deletions from the data sheet could be ma	ade without affecting the overall usefulness?					
6.	. Is there any incorrect or misleading information	(what and where)?					
7.	. How would you improve this document?						
8.	. How would you improve our software, systems,	and silicon products?					

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO. Device	X Temperature Range	/XX Package	Exa a) b)	amples: MCP6041-I/P: Indepackage. MCP6042-I/SN:	dustrial temp	perature, PDIP
Device:	MCP6041: MCP6041T: MCP6042: MCP6042T: MCP6043: MCP6043T: MCP6044: MCP6044T:	(Tape and Reel for SOIC and TSSOP) CMOS Single Op Amp w/CS Function CMOS Single Op Amp w/CS Function (Tape and Reel for SOIC and MSOP) CMOS Quad Op Amp	p Amp p Amp for SOIC and MSOP) Amp for SOIC and TSSOP) p Amp w/CS Function p Amp w/CS Function for SOIC and MSOP) h Amp Amp	MSOP package. d) MCP6044-I/SL: SIOC package.	Industrial Industrial Industrial	temperature, temperature, temperature,
Temperature Range: Package:	MS = P = SN = SL = ST =	Plastic MSOP, 8-lead Plastic DIP (300 mil Body), 8-lead, 14-lead Plastic SOIC (150 mil Body), 8-lead Plastic SOIC (150 mil Body), 14-lead Plastic TSSOP (4.4mm Body), 14-lead				

Sales and Support

Data Sheets

Products supported by a preliminary Data Sheet may have an errata sheet describing minor operational differences and recommended workarounds. To determine if an errata sheet exists for a particular device, please contact one of the following:

- 1. Your local Microchip sales office
- 2. The Microchip Corporate Literature Center U.S. FAX: (480) 792-7277
- 3. The Microchip Worldwide Site (www.microchip.com)

Please specify which device, revision of silicon and Data Sheet (include Literature #) you are using.

New Customer Notification System

Register on our web site (www.microchip.com/cn) to receive the most current information on our products.

NOTES:

Information contained in this publication regarding device applications and the like is intended through suggestion only and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. No representation or warranty is given and no liability is assumed by Microchip Technology Incorporated with respect to the accuracy or use of such information, or infringement of patents or other intellectual property rights arising from such use or otherwise. Use of Microchip's products as critical components in life support systems is not authorized except with express written approval by Microchip. No licenses are conveyed, implicitly or otherwise, under any intellectual property rights.

Trademarks

The Microchip name and logo, the Microchip logo, PIC, PICmicro, PICMASTER, PICSTART, PRO MATE, KEELOQ, SEEVAL, MPLAB and The Embedded Control Solutions Company are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

Total Endurance, ICSP, In-Circuit Serial Programming, Filter-Lab, MXDEV, microID, FlexROM, fuzzyLAB, MPASM, MPLINK, MPLIB, PICC, PICDEM, PICDEM.net, ICEPIC, Migratable Memory, FanSense, ECONOMONITOR, Select Mode and microPort are trademarks of Microchip Technology Incorporated in the U.S.A.

Serialized Quick Term Programming (SQTP) is a service mark of Microchip Technology Incorporated in the U.S.A.

All other trademarks mentioned herein are property of their respective companies.

© 2001, Microchip Technology Incorporated, Printed in the U.S.A., All Rights Reserved.





Microchip received QS-9000 quality system certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona in July 1999. The Company's quality system processes and procedures are QS-9000 compliant for its PICmicro® 8-bit MCUs, KEELOQ® code hopping devices, Serial EEPROMs and microperipheral products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001 certified.



WORLDWIDE SALES AND SERVICE

AMERICAS

Corporate Office

2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: 480-792-7627 Web Address: http://www.microchip.com

Rocky Mountain

2355 West Chandler Blvd. Chandler, AZ 85224-6199
Tel: 480-792-7966 Fax: 480-792-7456

Atlanta

500 Sugar Mill Road, Suite 200B Atlanta, GA 30350 Tel: 770-640-0034 Fax: 770-640-0307

Austin - Analog

13740 North Highway 183 Building J, Suite 4 Austin, TX 78750

Tel: 512-257-3370 Fax: 512-257-8526

Boston

2 Lan Drive, Suite 120 Westford, MA 01886 Tel: 978-692-3848 Fax: 978-692-3821

Boston - Analog

Unit A-8-1 Millbrook Tarry Condominium 97 Lowell Road Concord, MA 01742

Tel: 978-371-6400 Fax: 978-371-0050

Chicago

333 Pierce Road, Suite 180

Itasca, IL 60143 Tel: 630-285-0071 Fax: 630-285-0075

Dallas

4570 Westgrove Drive, Suite 160 Addison, TX 75001 Tel: 972-818-7423 Fax: 972-818-2924

Dayton

Two Prestige Place, Suite 130 Miamisburg, OH 45342 Tel: 937-291-1654 Fax: 937-291-9175

Detroit

Tri-Atria Office Building 32255 Northwestern Highway, Suite 190 Farmington Hills, MI 48334 Tel: 248-538-2250 Fax: 248-538-2260

Los Angeles 18201 Von Karman, Suite 1090 Irvine, CA 92612

Tel: 949-263-1888 Fax: 949-263-1338

New York

150 Motor Parkway, Suite 202 Hauppauge, NY 11788 Tel: 631-273-5305 Fax: 631-273-5335

San Jose

Microchip Technology Inc. 2107 North First Street, Suite 590 San Jose, CA 95131 Tel: 408-436-7950 Fax: 408-436-7955

Toronto

6285 Northam Drive, Suite 108 Mississauga, Ontario L4V 1X5, Canada Tel: 905-673-0699 Fax: 905-673-6509

ASIA/PACIFIC

Australia

Microchip Technology Australia Pty Ltd Suite 22, 41 Rawson Street Epping 2121, NSW Australia

Tel: 61-2-9868-6733 Fax: 61-2-9868-6755

China - Beijing

Microchip Technology Consulting (Shanghai) Co., Ltd., Beijing Liaison Office

Bei Hai Wan Tai Bldg. No. 6 Chaoyangmen Beidajie Beijing, 100027, No. China Tel: 86-10-85282100 Fax: 86-10-85282104

China - Chengdu

Microchip Technology Consulting (Shanghai) Co., Ltd., Chengdu Liaison Office

Rm. 2401, 24th Floor, Ming Xing Financial Tower No. 88 TIDU Street

Chengdu 610016, China Tel: 86-28-6766200 Fax: 86-28-6766599

China - Fuzhou

Microchip Technology Consulting (Shanghai) Co., Ltd., Fuzhou Liaison Office Rm. 531, North Building Fujian Foreign Trade Center Hotel 73 Wusi Road

Fuzhou 350001, China

Tel: 86-591-7557563 Fax: 86-591-7557572

China - Shanghai

Microchip Technology Consulting (Shanghai)

Co., Ltd. Room 701, Bldg. B

Far East International Plaza No. 317 Xian Xia Road Shanghai, 200051

Tel: 86-21-6275-5700 Fax: 86-21-6275-5060

China - Shenzhen

Microchip Technology Consulting (Shanghai) Co., Ltd., Shenzhen Liaison Office Rm. 1315, 13/F, Shenzhen Kerry Centre, Renminnan Lu

Shenzhen 518001, China

Tel: 86-755-2350361 Fax: 86-755-2366086

Hong Kong

Microchip Technology Hongkong Ltd. Unit 901-6, Tower 2, Metroplaza 223 Hing Fong Road Kwai Fong, N.T., Hong Kong Tel: 852-2401-1200 Fax: 852-2401-3431

India

Microchip Technology Inc. India Liaison Office Divyasree Chambers 1 Floor, Wing A (A3/A4) No. 11, O'Shaugnessey Road Bangalore, 560 025, India Tel: 91-80-2290061 Fax: 91-80-2290062 Japan

Microchip Technology Japan K.K. Benex S-1 6F 3-18-20, Shinyokohama Kohoku-Ku, Yokohama-shi Kanagawa, 222-0033, Japan

Tel: 81-45-471-6166 Fax: 81-45-471-6122

Korea

Microchip Technology Korea 168-1, Youngbo Bldg. 3 Floor Samsung-Dong, Kangnam-Ku

Seoul, Korea 135-882

Tel: 82-2-554-7200 Fax: 82-2-558-5934

Singapore

Microchip Technology Singapore Pte Ltd. 200 Middle Road #07-02 Prime Centre

Singapore, 188980 Tel: 65-334-8870 Fax: 65-334-8850

Taiwan

Microchip Technology Taiwan 11F-3, No. 207 Tung Hua North Road Taipei, 105, Taiwan

Tel: 886-2-2717-7175 Fax: 886-2-2545-0139

EUROPE

Denmark

Microchip Technology Denmark ApS Regus Business Centre Lautrup hoj 1-3 Ballerup DK-2750 Denmark Tel: 45 4420 9895 Fax: 45 4420 9910

France

Arizona Microchip Technology SARL Parc d'Activite du Moulin de Massy 43 Rue du Saule Trapu Batiment A - Ier Etage 91300 Massy, France Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

Germany

Arizona Microchip Technology GmbH Gustav-Heinemann Ring 125 D-81739 Munich, Germany Tel: 49-89-627-144 0 Fax: 49-89-627-144-44

Germany - Analog

Lochhamer Strasse 13 D-82152 Martinsried, Germany Tel: 49-89-895650-0 Fax: 49-89-895650-22

Arizona Microchip Technology SRL Centro Direzionale Colleoni Palazzo Taurus 1 V. Le Colleoni 1 20041 Agrate Brianza

Milan, Italy
Tel: 39-039-65791-1 Fax: 39-039-6899883

United Kingdom

Arizona Microchip Technology Ltd. 505 Eskdale Road Winnersh Triangle Wokingham Berkshire, England RG41 5TU Tel: 44 118 921 5869 Fax: 44-118 921-5820

08/01/01